

Search Notes**Application/Control No.**

10/825,594

Examiner

Tai Duong

Applicant(s)/Patent under Reexamination

LEE, YUN-BOK

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	38	6/17/2006	TD
39			
43			
110			
14			
146			
187			
257	59		
72			
345	92		
438	30		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	6/17/2006	TD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner